# N-Channel Power MOSFET 500 V, 2.7 $\Omega$

#### **Features**

- Low ON Resistance
- Low Gate Charge
- ESD Diode-Protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	500	V
Continuous Drain Current $R_{\theta JC}$	I <sub>D</sub>	3.0	Α
Continuous Drain Current $R_{\theta JC}$ , $T_A = 100^{\circ}C$	I <sub>D</sub>	1.9	Α
Pulsed Drain Current, V <sub>GS</sub> @ 10 V	I <sub>DM</sub>	12	Α
Power Dissipation $R_{\theta JC}$	$P_{D}$	61	W
Gate-to-Source Voltage	V <sub>GS</sub>	±30	٧
Single Pulse Avalanche Energy, I <sub>D</sub> = 3.4 A	E <sub>AS</sub>	120	mJ
ESD (HBM) (JESD22-A114)	V <sub>esd</sub>	2800	V
Peak Diode Recovery	dv/dt	4.5 (Note 1)	V/ns
Continuous Source Current (Body Diode)	I <sub>S</sub>	3.4	Α
Maximum Temperature for Soldering Leads	TL	260	°C
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

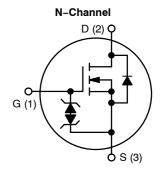
1.  $I_D \leq 3.4$  A,  $di/dt \leq 200$  A/ $\mu$ s,  $V_{DD} \leq BV_{DSS}$ ,  $T_J \leq 150^{\circ}C$ .



#### ON Semiconductor®

http://onsemi.com

V <sub>DSS</sub>	R <sub>DS(on)</sub> (MAX) @ 1.5 A
500 V	2.7 Ω







IPAK CASE 369D STYLE 2

DPAK CASE 369AA STYLE 2

#### MARKING AND ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE

Parameter			Value	Unit
Junction-to-Case (Drain)	NDD04N50Z	$R_{ heta JC}$	2.0	°C/W
Junction-to-Ambient Steady State	(Note 3) NDD04N50Z (Note 2) NDD04N50Z-1	$R_{ heta JA}$	40 80	

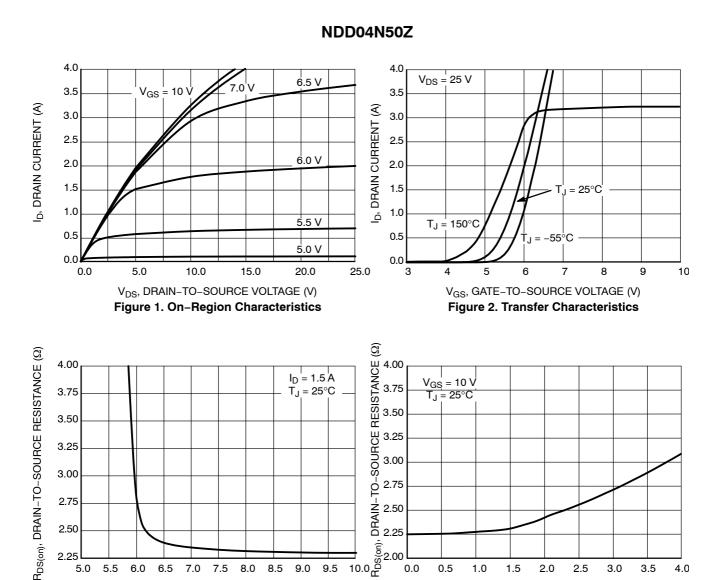
<sup>2.</sup> Insertion mounted

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	_			•	•	•
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 n	nΑ	500			V
Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/$ $\Delta T_{J}$	Reference to 25°C I <sub>D</sub> = 1 mA	Э,		0.6		V/°C
Drain-to-Source Leakage Current	I <sub>DSS</sub>	V 500 V V 0 V	25°C			1.0	μΑ
		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V	150°C			50	1
Gate-to-Source Forward Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ±20 V				±10	μΑ
ON CHARACTERISTICS (Note 4)		•					-
Static Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 1.9$	5 A		2.3	2.7	Ω
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 50$	μΑ	3.0		4.5	V
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1.5 A			2.1		S
DYNAMIC CHARACTERISTICS	•	•			•	•	
Input Capacitance (Note 5)	C <sub>iss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		246	308	370	pF
Output Capacitance (Note 5)	C <sub>oss</sub>			33	43	53	
Reverse Transfer Capacitance (Note 5)	C <sub>rss</sub>			7.0	9.0	11	
Total Gate Charge (Note 5)	Qg	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 3.4 A,		6.0	12	18	nC
Gate-to-Source Charge (Note 5)	$Q_{gs}$			1.3	2.6	4.0	1
Gate-to-Drain ("Miller") Charge (Note 5)	$Q_{gd}$	V <sub>GS</sub> = 10 V		3.5	6.1	7.0	1
Plateau Voltage	$V_{GP}$				6.6		V
Gate Resistance	$R_g$			1.8	5.4	16.2	Ω
RESISTIVE SWITCHING CHARACTERISTI	cs						
Turn-On Delay Time	t <sub>d(on)</sub>				9.0		ns
Rise Time	t <sub>r</sub>	$V_{DD} = 250 \text{ V}, I_D = 3.4$	4 A,		9.0		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10 \text{ V}, R_{G} = 5$	Ω		16		
Fall Time	t <sub>f</sub>	1			10		
SOURCE-DRAIN DIODE CHARACTERIST	ICS (T <sub>C</sub> = 25	°C unless otherwise noted)					
Diode Forward Voltage	$V_{SD}$	I <sub>S</sub> = 3.4 A, V <sub>GS</sub> = 0	V			1.6	V
Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 30	o V		240		ns
Reverse Recovery Charge	$Q_{rr}$	$I_S = 3.4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$			0.9		μC

Pulse Width ≤ 380 μs, Duty Cycle ≤ 2%.
 Guaranteed by design.

<sup>3.</sup> Surface mounted on FR4 board using 1'' sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces).



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 3. On-Region versus Gate-to-Source Voltage

8.0

8.5

9.0

9.5

7.0 7.5

2.50

5.0 5.5

ID, DRAIN CURRENT (A) Figure 4. On-Resistance versus Drain **Current and Gate Voltage** 

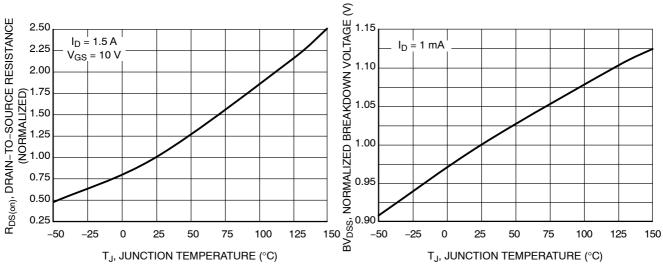
2.0

2.5

3.0

3.5

4.0



10.0<sub>(oi)</sub>,

0.0

0.5

1.0

1.5

Figure 5. On-Resistance Variation with **Temperature** 

Figure 6. BV<sub>DSS</sub> Variation with Temperature

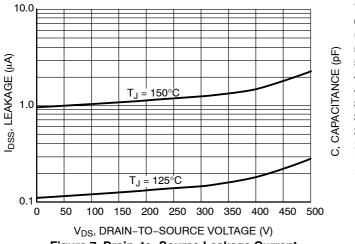
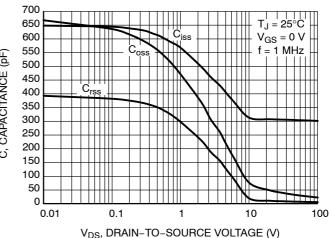


Figure 7. Drain-to-Source Leakage Current versus Voltage





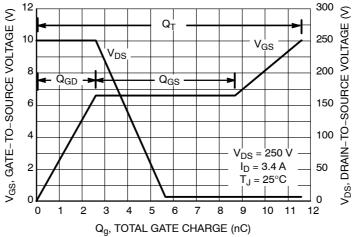


Figure 9. Gate-to-Source Voltage and Drain-to-Source Voltage versus Total Charge

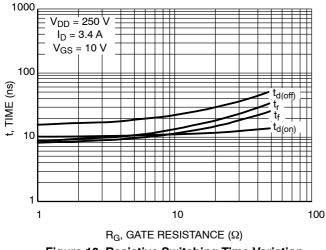


Figure 10. Resistive Switching Time Variation versus Gate Resistance

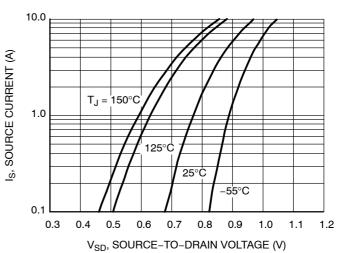


Figure 11. Diode Forward Voltage versus Current

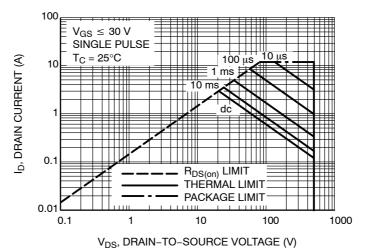


Figure 12. Maximum Rated Forward Biased Safe Operating Area NDD04N50Z

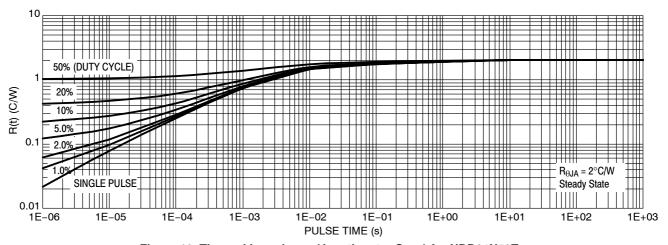


Figure 13. Thermal Impedance (Junction-to-Case) for NDD04N50Z

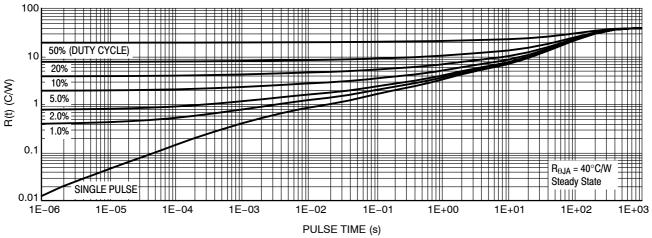


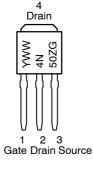
Figure 14. Thermal Impedance (Junction-to-Ambient) for NDD04N50Z

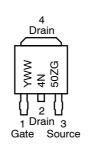
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NDD04N50Z-1G	IPAK (Pb-Free)	75 Units / Rail
NDD04N50ZT4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **MARKING DIAGRAMS**





A = Location Code

Y = Year WW = Work Week

G = Pb-Free Package

STYLE 1: PIN 1. BASE

3.

STYLE 5: PIN 1. GATE

2. COLLECTOR

EMITTER

4. COLLECTOR

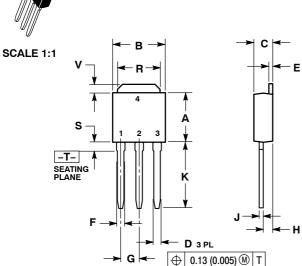
ANODE
 CATHODE

ANODE





**DATE 15 DEC 2010** 



STYLE 2: PIN 1. GATE

3.

STYLE 6: PIN 1. MT1

2. DRAIN

4. DRAIN

MT2
 GATE

MT2

SOURCE

STYLE 3: PIN 1. ANODE

STYLE 7:

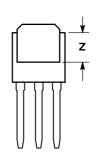
PIN 1. GATE

2. CATHODE

3. ANODE4. CATHODE

2. COLLECTOR 3. EMITTER

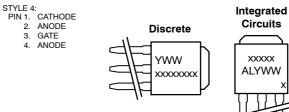
COLLECTOR



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

#### **MARKING DIAGRAMS**



xxxxxxxxx = Device Code = Assembly Location IL = Wafer Lot Υ = Year WW = Work Week

DOCUMENT NUMBER:	98AON10528D	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	IPAK (DPAK INSERTION MOUNT)		PAGE 1 OF 1

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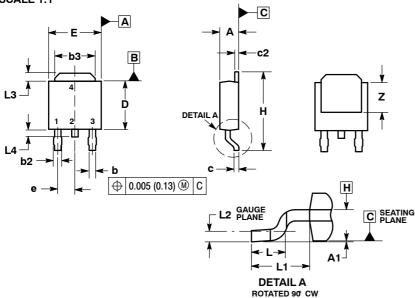
**DATE 03 JUN 2010** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- 3. HEHMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.

  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74 REF	
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



# STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER

PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE

STYLE 5:

4. COLLECTOR

# STYLE 2:

PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### STYLE 3: PIN 1. ANODE 2. CATHODE

3. ANODE 4. CATHODE

#### STYLE 4: PIN 1. CATHODE 2. ANODE

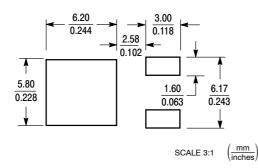
3. GATE 4. ANODE

STYLE 6: PIN 1. MT1 2. MT2 3. GATE 4. MT2

PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR

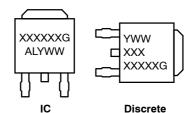
STYLE 7:

## **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot Υ = Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

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